4.6 Photos of Radiation Measuring Setup



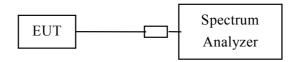


5.6 Photos of Conduction Measuring Setup





Figure 4: Measurement configuration.





7.3 Measurement Equipment

Equipment	Manufacturer	Model No.	Next Cal. Due
Spectrum Analyzer	Rohde & Schwarz	FSP	06/30/2005
Attenuator	Weinschel Engineering	1	N/A

7.4 Measurement Data

Test Date: MAY 20, 2005 Temperature: 20 °C Humidity: 65 %

a) Channel Low : Adjacent Hopping Channel Separation is 1000 kHz
b) Channel Middle : Adjacent Hopping Channel Separation is 1000 kHz
c) Channel High : Adjacent Hopping Channel Separation is 1000 kHz

Note: 1. Please see appendix 2 for Plotted Data

2. The expanded uncertainty of the hopping channel separation tests is 2dB.